Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/682,049	ITO ET AL.
Examiner	**Art Unit**
Y. J. Han	2838

SEARCHED			
Class	Subclass	Date	Examiner
323	222		
	247		
	282		
	284		
	290		
	225		
	301		
	351		
219	502	3/05	GR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
323	**225**		
	247		
	290	3/05	GR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR